Search Notes			

Application/Control N	Applicant(s)/Patent under Reexamination	
10/617,033	AMADA ET AL.	
Examiner	Art Unit	
Hai C. Pham	2861	

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	SEARCHED			
Class	Subclass	Date	Examiner	
347	235-239, 246-250, 255, 135	11/18/2005	НР	
	136			
349	1-3	11/18/2005	HP	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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